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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/771,729	02/04/2004	Yoshinori Iketaki	17403	4044
1933	7590 04/19/2006		EXAMINER	
FRISHAUF, HOLTZ, GOODMAN & CHICK, PC 220 Fifth Avenue			DETSCHEL, MARISSA	
16TH Floor		ART UNIT	PAPER NUMBER	
NEW YORK, NY 10001-7708			2877	
		•	DATE MAILED: 04/19/200	6

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)	
Supplemental	10/771,729	IKETAKI ET AL.	
Notice of Allowability .	Examiner	Art Unit	
	Marissa J. Detschel	2877	
The MAILING DATE of this communication ap All claims being allowable, PROSECUTION ON THE MERITS herewith (or previously mailed), a Notice of Allowance (PTOL- NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT of the Office or upon petition by the applicant. See 37 CFR 1.3	IS (OR REMAINS) CLOSED in 85) or other appropriate communication is s	this application. If not included inication will be mailed in due co	d ourse. <b>THIS</b>
1. $igotimes$ This communication is responsive to <u>Application filed Ju</u>	ıly 8, 2004.		
2. The allowed claim(s) is/are <u>1-9</u> .		•	•
<ul> <li>3.  Acknowledgment is made of a claim for foreign priority</li> <li>a)  All b)  Some* c)  None of the:</li> <li>1.  Certified copies of the priority documents hete</li> <li>2.  Certified copies of the priority documents hete</li> <li>3.  Copies of the certified copies of the priority International Bureau (PCT Rule 17.2(a)).</li> </ul>	ave been received. ave been received in Applicatio	n No	on from the
* Certified copies not received:	•		
Applicant has THREE MONTHS FROM THE "MAILING DAT noted below. Failure to timely comply will result in ABANDO THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		a reply complying with the requ	uirements
4. A SUBSTITUTE OATH OR DECLARATION must be su INFORMAL PATENT APPLICATION (PTO-152) which (			OTICE OF
<ol> <li>CORRECTED DRAWINGS (as "replacement sheets") r</li> <li>(a) ☐ including changes required by the Notice of Draftsp</li> <li>1) ☐ hereto or 2) ☐ to Paper No./Mail Date</li> <li>(b) ☐ including changes required by the attached Examin Paper No./Mail Date</li> </ol>	erson's Patent Drawing Review		
Identifying indicia such as the application number (see 37 CF each sheet. Replacement sheet(s) should be labeled as such	R 1.84(c)) should be written on the in the header according to 37 CF	ne drawings in the front (not the l R 1.121(d).	back) of
<ol> <li>DEPOSIT OF and/or INFORMATION about the de attached Examiner's comment regarding REQUIREMENT</li> </ol>	posit of BIOLOGICAL MATE NT FOR THE DEPOSIT OF BIO	ERIAL must be submitted. No DLOGICAL MATERIAL.	ote the
Attachment(s)			
1. Notice of References Cited (PTO-892)	5. Notice of In	formal Patent Application (PTO	-152)
2.  Notice of Draftperson's Patent Drawing Review (PTO-94		ımmary (PTO-413),	
3. Information Disclosure Statements (PTO-1449 or PTO/S	Paper No./ B/08), 7. ☐ Examiner's	Mail Date Amendment/Comment	
Paper No./Mail Date  4. Examiner's Comment Regarding Requirement for Depos	sit 8. ⊠ Examiner's	Statement of Reasons for Allov	vance
of Biological Material	9.  Other	_·	
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## **EXAMINER'S AMENDMENT**

Page 2

This examiner's amendment is a supplemental action in response to a correction of the amendment submitted April 3, 2006, by the Examiner, indicating an incorrect title change. The following amendment indicates the corrected title change as set forth below.

An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Leonard Holts (RN 22,974) on March 22, 2006.

The application has been amended as follows:

In regards to claim 5, lines 2-3, the phrase "the spatial phase distribution measuring portion" has been replaced with --a spatial phase distribution measuring portion--.

In regards to claim 7, line 1, the phrase "the control unit" has been replaced with - a control unit--.

In regards to claim 9, line 10, the phrase "a means provided" has been replaced with --a means for wavefront compensation provided--

In regards to the title, the original title of "Microscope" has been changed to -Microscope with Wavefront Compensation--

## Examiner's Reasons for Allowance

Claims 1-9 are allowed over the prior art of record.

The following is an examiner's statement of reasons for allowance:

As to claims 1 and 9, the prior art of record, taken alone or in combination, fails to disclose or render obvious the use of a wavefront compensator and a wavefront aberration removal section affiliated with the removal of aberration created by the wavefront compensator in a microscope utilizing a spatial phase modulator to shape first and second beams to excite electrons in a molecule for measurement, in combination with the rest of the limitations of claims 1 and 9.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

## **Priority**

Acknowledgment is made of applicant's claim for foreign priority under 35 U.S.C. 119(a)-(d). The certified copy has been filed in parent Application No. 2003-26,796, filed on February 4, 2003.

#### Pertinent Prior Art

The prior art of record and not relied upon is considered pertinent to applicant's disclosure. The prior art of record is Iketaki et al. (USPN 6,859,313).

Application/Control Number: 10/771,729

Art Unit: 2877

Page 4

Iketaki discloses a microscope comprising a spatial phase modulator to shape first and second beams to excite electrons in a molecule for measurement of fluorescence due to an overlapping of the first and second shaped beams.

#### Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Marissa J. Detschel whose telephone number is 571-272-2716. The examiner can normally be reached on M-F 8:30am-5:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Gregory J. Toatley, Jr. can be reached on 571-272-2059. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Marissa J Detschel

April 11, 2006

Hoa Q. Pham

Primary Examiner